
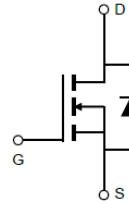
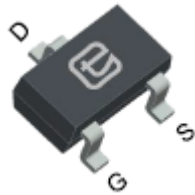


**20V N-Channel Trench MOSFET(Preliminary)**

<p><b>General Description</b></p> <ul style="list-style-type: none"> <li>● Trench Power technology</li> <li>● Low <math>R_{DS(ON)}</math></li> <li>● Low Gate Charge</li> <li>● Optimized for fast-switching applications</li> </ul> <p><b>Applications</b></p> <ul style="list-style-type: none"> <li>● Synchronous Rectification in DC/DC and AC/DC Converters</li> <li>● Isolated DC/DC Converters in Telecom and Industrial</li> </ul>	<p><b>Product Summary</b></p> <table> <tr> <td><math>V_{DS}</math></td> <td>20V</td> </tr> <tr> <td><math>I_D</math> (at <math>V_{GS}=10V</math>)</td> <td>3.7A</td> </tr> <tr> <td><math>R_{DS(ON)}</math> (at <math>V_{GS}=10V</math>)</td> <td>&lt; 24m<math>\Omega</math></td> </tr> <tr> <td><math>R_{DS(ON)}</math> (at <math>V_{GS}=4.5V</math>)</td> <td>&lt; 27m<math>\Omega</math></td> </tr> <tr> <td><math>R_{DS(ON)}</math> (at <math>V_{GS}=2.5V</math>)</td> <td>&lt; 37m<math>\Omega</math></td> </tr> </table> <div style="text-align: right;">  </div>	$V_{DS}$	20V	$I_D$ (at $V_{GS}=10V$ )	3.7A	$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 24m $\Omega$	$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 27m $\Omega$	$R_{DS(ON)}$ (at $V_{GS}=2.5V$ )	< 37m $\Omega$
$V_{DS}$	20V										
$I_D$ (at $V_{GS}=10V$ )	3.7A										
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 24m $\Omega$										
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$R_{DS(ON)}$ (at $V_{GS}=2.5V$ )	< 37m $\Omega$										

SOT-23



Part Number	Package Type	Form	Marking
TTX2302A	SOT-23	Tape&Reel	2302A

**Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$  unless otherwise noted)**

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>B</sup>	$I_D$	$T_C = 25^\circ\text{C}$	3.7
		$T_C = 70^\circ\text{C}$	3.7
Pulsed Drain Current <sup>A</sup>	$I_{DM}$	9	A
Avalanche Current <sup>A</sup>	$I_{AS}$	6	A
Single Pulse Avalanche Energy $L = 0.3\text{mH}$ <sup>A</sup>	$E_{AS}$	5.4	mJ
Power Dissipation <sup>C</sup>	$P_D$	$T_C = 25^\circ\text{C}$	0.89
		$T_C = 70^\circ\text{C}$	0.57
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ\text{C}$

**Thermal Characteristics**

Parameter	Symbol	Maximum	Units
Maximum Junction-to-Lead	$R_{\theta JL}$	120	$^\circ\text{C/W}$
Maximum Junction-to-Ambient			



Electrical Characteristics( $T_J = 25^\circ\text{C}$ unless otherwise noted)							
Symbol	Parameter	Conditions	Value			Units	
			Min	Typ	Max		
<b>STATIC PARAMETERS</b>							
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	20			V	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	$T_J = 25^\circ\text{C}$		1	$\mu\text{A}$	
			$T_J = 125^\circ\text{C}$		100		
$I_{GSS}$	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 12\text{V}$			$\pm 100$	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.45	0.7	0.95	V	
$R_{DS(on)}$	Static Drain-Source On-Resistance		$V_{GS} = 10\text{V}, I_D = 3\text{A}$		20	24	$\text{m}\Omega$
			$V_{GS} = 4.5\text{V}, I_D = 3\text{A}$		22	27	$\text{m}\Omega$
			$V_{GS} = 2.5\text{V}, I_D = 3\text{A}$		30	37	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 6\text{A}$		13		S	
$V_{SD}$	Diode Forward Voltage	$I_S = 3\text{A}, V_{GS} = 0\text{V}$			1	V	
$I_S$	Maximum Body-Diode Continuous Current <sup>B</sup>				3.7	A	
<b>DYNAMIC PARAMETERS</b>							
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 10\text{V}, f = 1\text{MHz}$		408		$\text{pF}$	
$C_{oss}$	Output Capacitance			60			
$C_{rss}$	Reverse Transfer Capacitance			53			
$R_g$	Gate Resistance	$f = 1\text{MHz}$		4		$\Omega$	
<b>SWITCHING PARAMETERS</b>							
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS} = 10\text{V}, V_{DS} = 10\text{V}, I_D = 3\text{A}$		10.5		nC	
$Q_g(4.5\text{V})$				5.1			
$Q_{gs}$	Gate Source Charge			1			
$Q_{gd}$	Gate Drain Charge			0.8			
$t_{D(on)}$	Turn-On Delay Time	$V_{GS} = 10\text{V}, V_{DS} = 10\text{V}, I_D = 3\text{A}, R_G = 2.5\Omega$		3.2		ns	
$t_r$	Turn-On Rise Time			2.4			
$t_{D(off)}$	Turn-Off Delay Time			17			
$t_f$	Turn-Off Fall Time			3.8			
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F = 3\text{A}, di/dt = 100\text{A}/\mu\text{s}$		4.6		ns	
$Q_{rr}$	Body Diode Reverse Recovery Charge			1.8		nC	

A. Single pulse width limited by maximum junction temperature.

B. The maximum current rating is package limited.

C. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

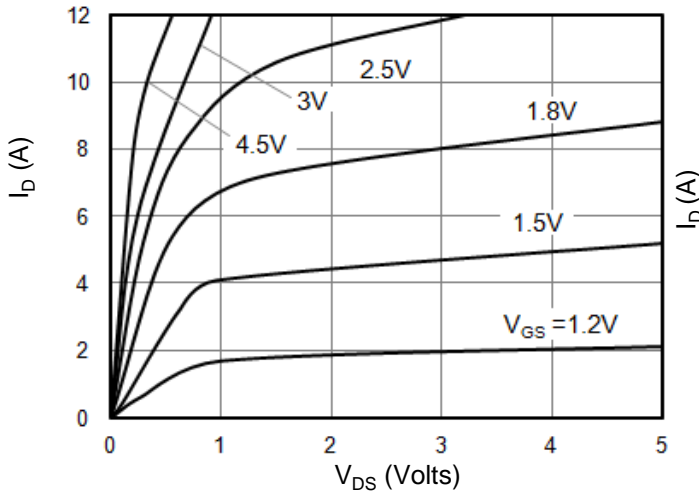


Figure 1: On-Region Characteristics

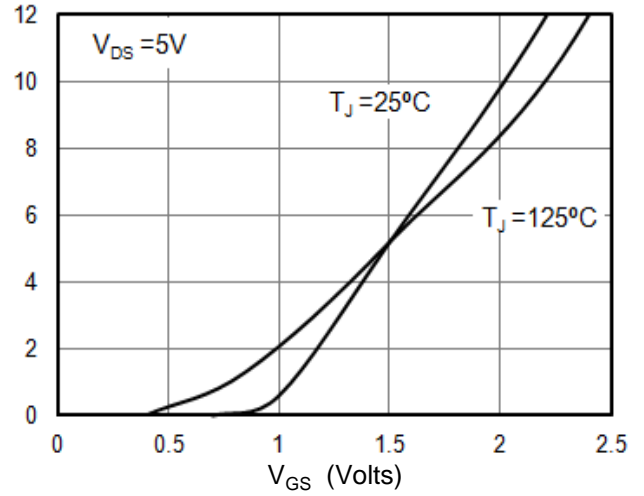


Figure 2: Transfer Characteristics

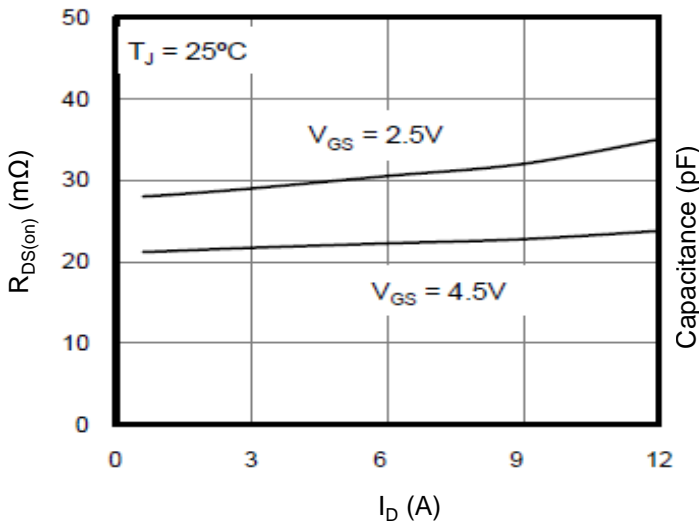


Figure 3: On-Resistance vs. Drain Current

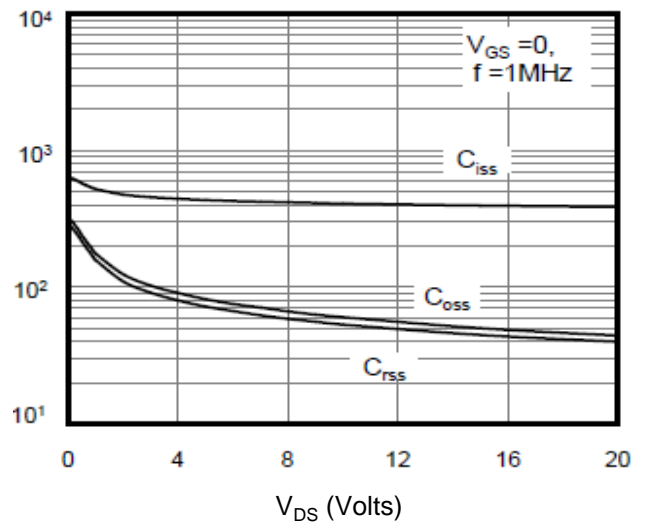


Figure 4: Capacitance Characteristics

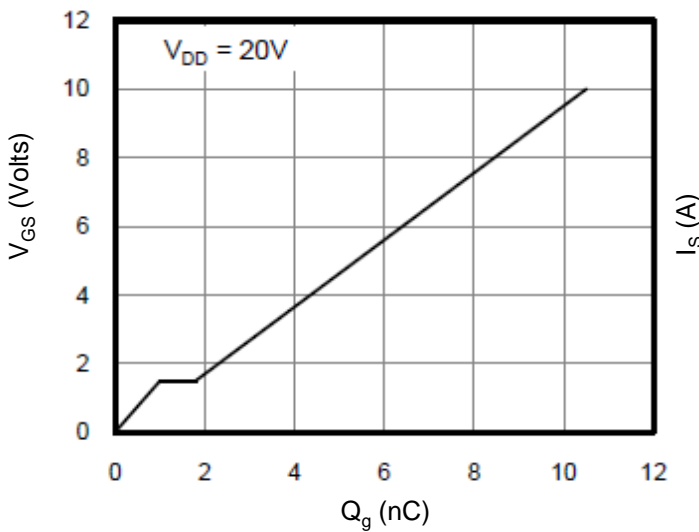


Figure 5: Gate Charge Characteristics

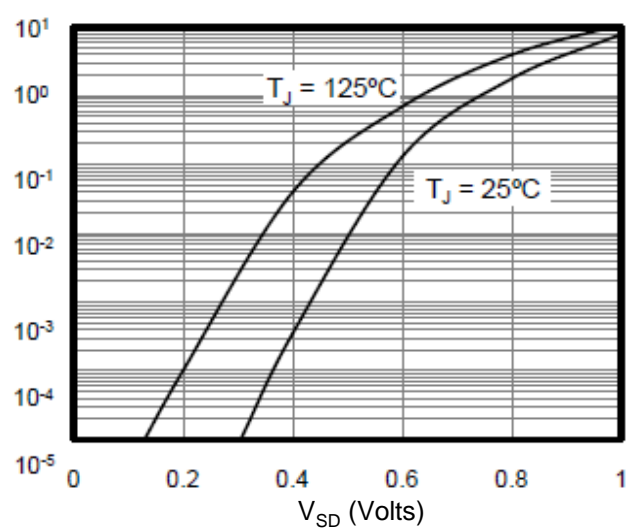


Figure 6: Body Diode Forward Voltage



### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

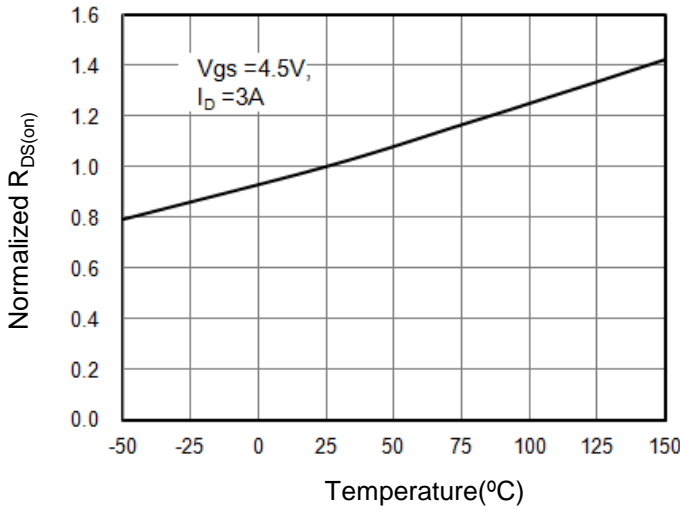


Figure 7: On-Resistance vs. Junction Temperature

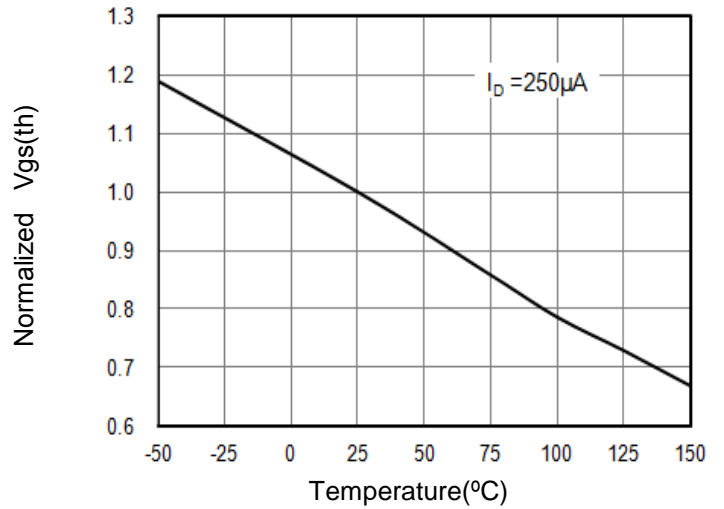


Figure 8:  $V_{GS(th)}$  vs. Junction Temperature

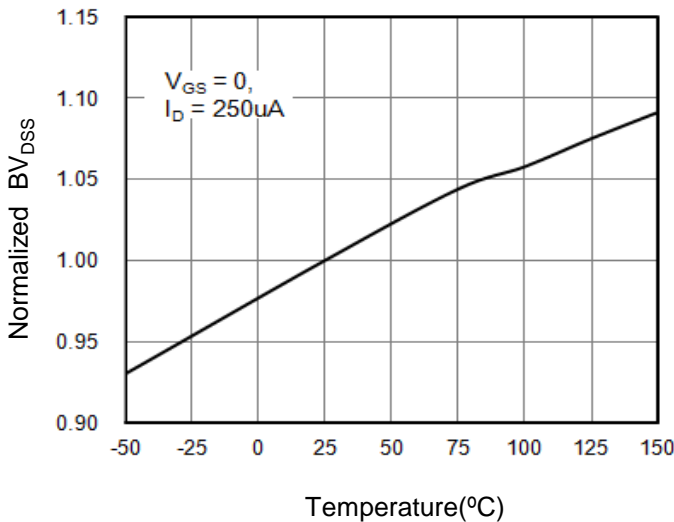


Figure 9:  $BV_{DS}$  vs. Junction Temperature

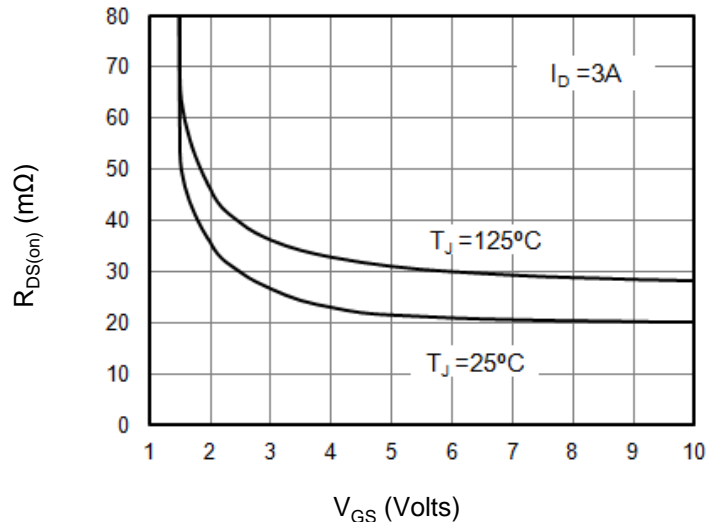


Figure 10: On-Resistance vs. Gate-Source Voltage

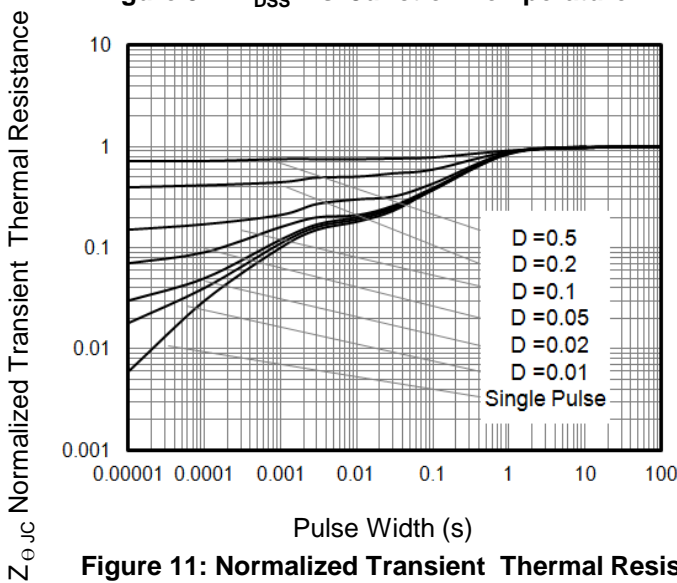


Figure 11: Normalized Transient Thermal Resistance

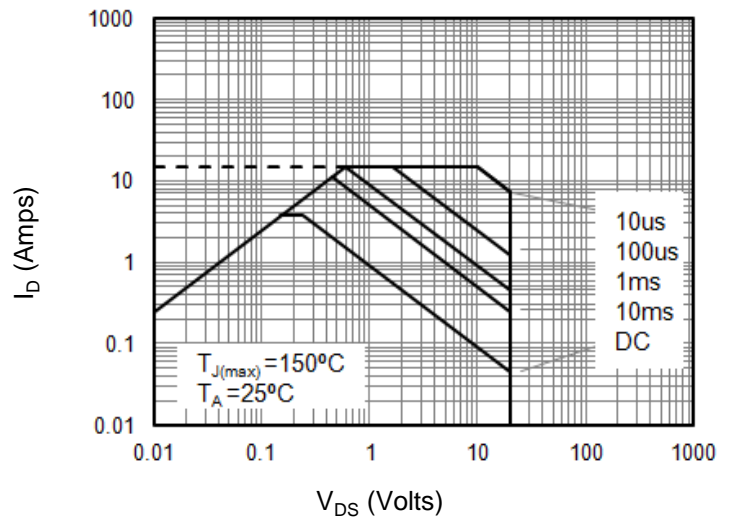


Figure 12: Safe Operating Area



Figure A: Gate Charge Test Circuit and Waveforms



Figure B: Resistive Switching Test Circuit and Waveforms

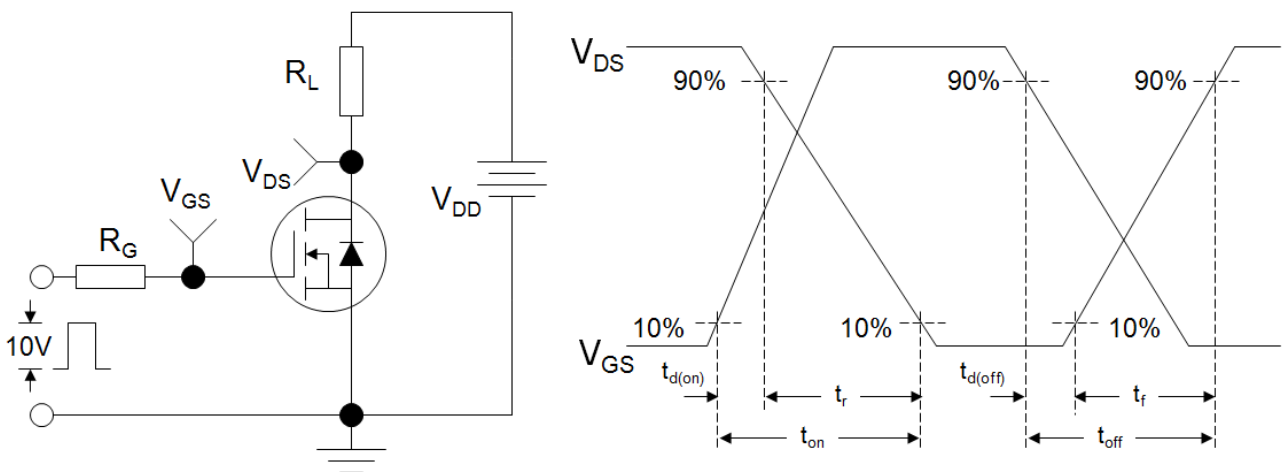
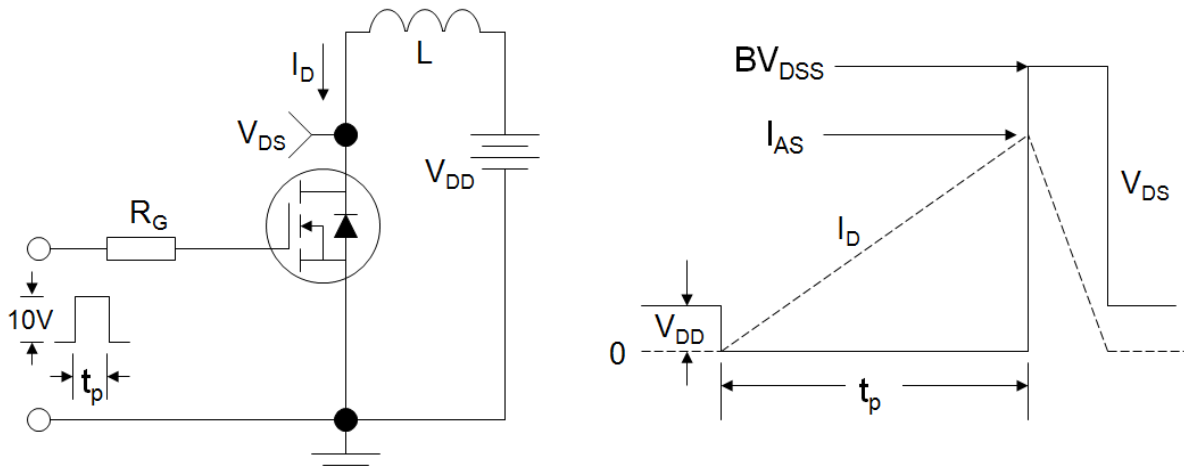
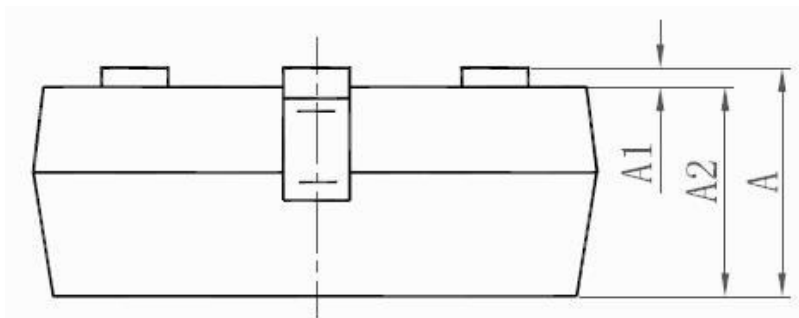
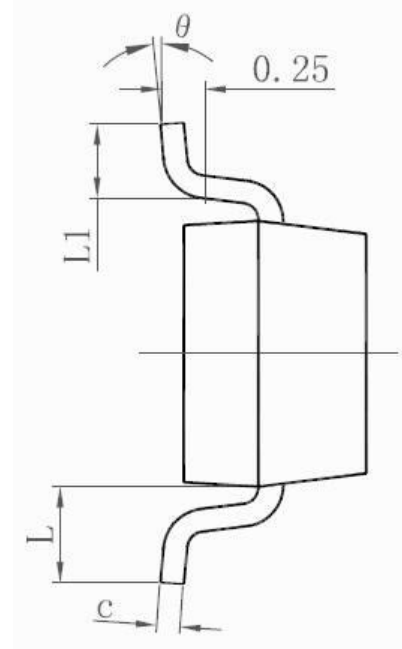
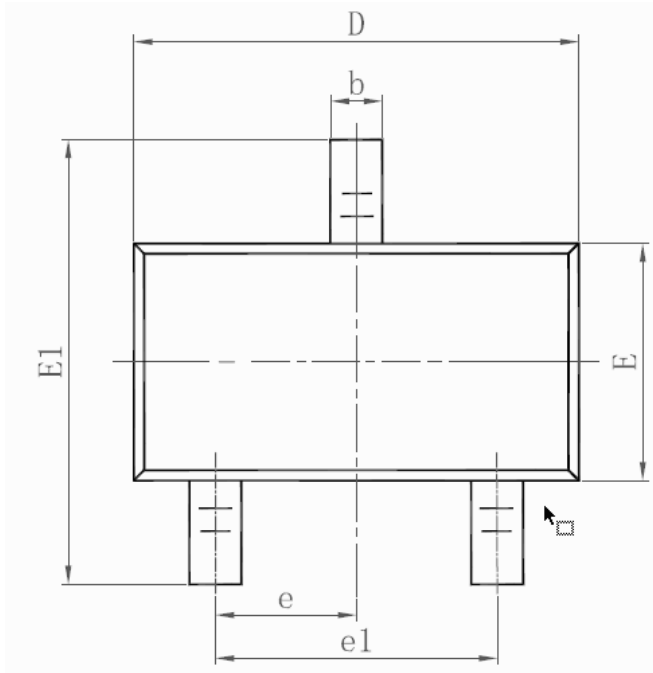


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms

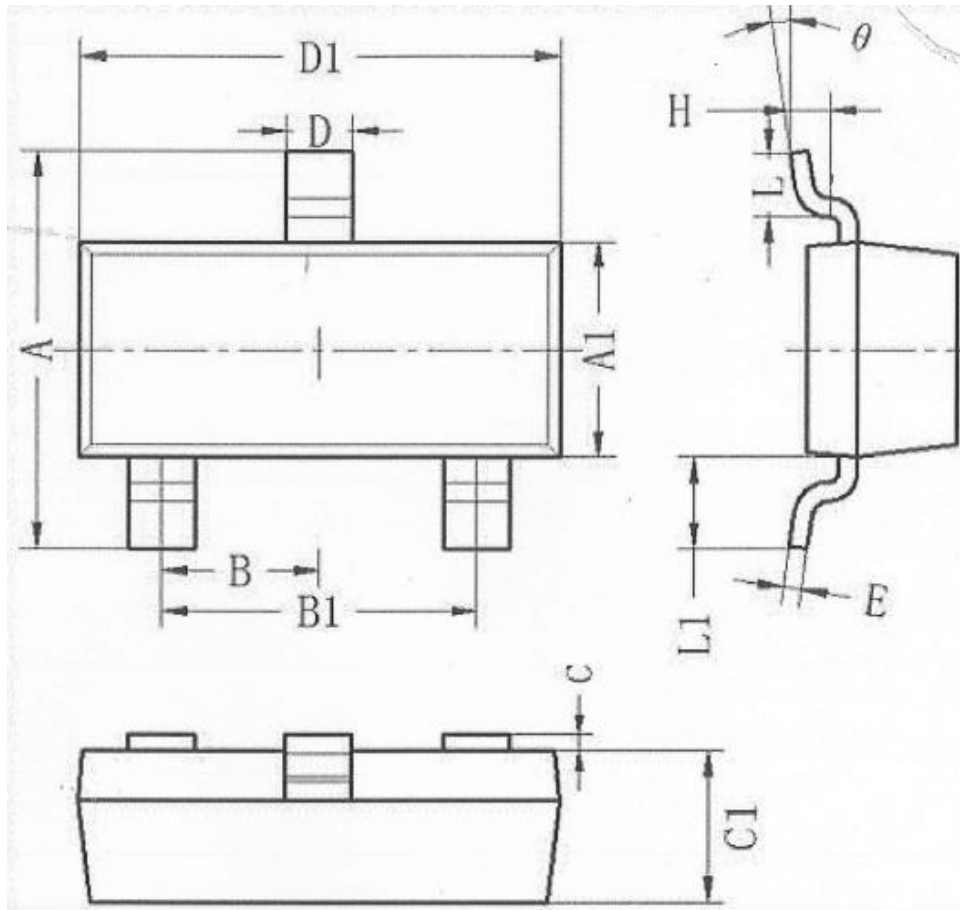


**SOT-23(K)**

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020
$\theta$	0°	8°	0°	8°



### SOT-23(N)



符号	标准	下公差	上公差	下限值	上限值
A	2.4	-0.15	0.15	2.25	2.55
A1	1.3	-0.1	0.1	1.2	1.4
B	0.95	-0.05	0.05	0.90	1.00
B1	1.9	-0.1	0.1	1.8	2
C	0.08	-0.06	0.06	0.02	0.14
C1	0.95	-0.05	0.05	0.9	1
D	0.4	-0.1	0.1	0.3	0.5
D1	2.9	-0.1	0.1	2.8	3
E	0.1	-0.03	0.03	0.07	0.13
H	0.25	-0.03	0.03	0.22	0.28
L	0.4	-0.1	0.1	0.3	0.5
L1	0.55	-0.07	0.07	0.48	0.62
θ	4	-3	3		7



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